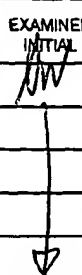

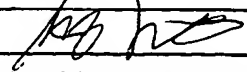


FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. IMEC215.001C1	APPLICATION NO. 10/630,439
INFORMATION DISCLOSURE STATEMENT BY APPLICANT  (USE SEVERAL SHEETS IF NECESSARY)		APPLICANT Meuris, et al.	
		FILING DATE July 29, 2003	GROUP Unknown

U.S. PATENT DOCUMENTS						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS
	1.	6,051,027	4/2000	Kapur et al.		
	2.	6,064,810	05/16/00	Raad et al.		
	3.	6,137,492	10/24/00	Hoppe		
	4.	6,266,062	07/24/01	Rivara		
	5.	6,453,275	9/2002	Schoenmaker		

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)	
	6.	Albanese, R., et al., "Numerical Procedures for the Solution of Nonlinear Electromagnetic Problems", IEEE Transactions on Magnetics, Vol. 28, No. 2, March 1992. XP-002181720
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	9.	H.K. Dirks, "Quasi-Stationary Fields for Microelectronic Applications", Electrical Engineering, Vol. 79, pgs. 145-155, 1996.
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EXAMINER	DATE CONSIDERED
	3/9/06
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